

### FINAL PRODUCT/PROCESS CHANGE NOTIFICATION

Generic Copy

### 16 Apr 2008

SUBJECT: ON Semiconductor Final Product/Process Change Notification #16111

**TITLE: PTC Products (former ADI Parts) Final Test Consolidation** 

PROPOSED FIRST SHIP DATE: 16 Jul 2008

AFFECTED CHANGE CATEGORY(S): Final Test

AFFECTED PRODUCT DIVISION(S): Computing Products

### FOR ANY QUESTIONS CONCERNING THIS NOTIFICATION:

Contact your local ON Semiconductor Sales Office or Tom Opazo<a href="mailto:Contact your local">Contact your local ON Semiconductor Sales Office or Tom Opazo</a><a href="mailto:Contact your local">Contact your local ON Semiconductor Sales Office or Tom Opazo</a><a href="mailto:Contact your local">Contact your local ON Semiconductor Sales Office or Tom Opazo</a><a href="mailto:Contact your local">Contact your local ON Semiconductor Sales Office or Tom Opazo</a><a href="mailto:Contact your local">Contact your local ON Semiconductor Sales</a><a href="mailto:Contact your local">Contact your local ON Semiconductor Sales</a><a href="mailto:Contact your local">Contact your local ON Semiconductor Sales</a><a href="mailto:Contact your local">Contact your local your lo

**SAMPLES:** Contact your local ON Semiconductor Sales Office

#### **NOTIFICATION TYPE:**

Final Product/Process Change Notification (FPCN)

Final change notification sent to customers. FPCNs are issued at least 90 days prior to implementation of the change.

ON Semiconductor will consider this change approved unless specific conditions of acceptance are provided in writing within 30 days of receipt of this notice. To do so, contact your local ON Semiconductor Sales Office.

### **DESCRIPTION AND PURPOSE:**

ON Semiconductor is notifying customers about changes to certain products that will undergo Final Test location changes from former ADI test locations to ON Semiconductor final test locations. These test site locations will be from Cavite Philippines (ADI) to Carmona Philippines (ON Semi). Some products will undergo just a location change and be tested on the same test platform using the same test program; just a different test location and some products will be tested on a different test platform in a different location. Regardless of the type of change, ON Semiconductor has completed validation and verification correlation studies between the testers and sites to ensure that the programs are effective and accuracy and repeatability are the same or better in the new location

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### **ELECTRICAL CHARACTERISTIC SUMMARY:**

Can be provided upon request

### **CHANGED PART IDENTIFICATION:**

Changed parts will be identified by date code. Products with date codes after July 7, 2008 may be tested from new site. ON Semiconductor would like to reduce the cycle time to implement this change and may work with customers for earlier approval for implementation.

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# **ON Semiconductor**



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### AFFECTED DEVICE LIST

AD51/057Z-000

AD51/057Z-0REEL

AD51/057Z-0REEL7

AD51/067ARMZ-2RL

AD51/067ARMZ-R

AD51-067ARMZ-R

ADM1026JSTZ

ADM1026JSTZ-R7

ADM1026JSTZ-REEL

ADM1029ARQZ

ADM1029ARQZ-R7

ADM1032ARMZ

ADM1032ARMZ-001

ADM1032ARMZ-002

ADM1032ARMZ-1

ADM1032ARMZ-1RL

ADM1032ARMZ-2

ADM1032ARMZ-2R

ADM1032ARMZ-2RL7

ADM1032ARMZ-R7

ADM1032ARMZ-REEL

ADM1032ARZ

ADM1032ARZ-001

ADM1032ARZ-1

ADM1032ARZ-1REEL

ADM1032ARZ-1RL7

ADM1032ARZ-REEL

ADM1032ARZ-REEL7

ADP0700JCPZ-RL

ADP31890001CPZR

ADP31890002CPZR

ADP3189JCPZ-R7

ADP3189JCPZ-RL ADP3190AJRQZ-RL

ADP3190AJRUZ-RL

ADP3190JRQZ-RL

ADP3190JRUZ-RL

ADP31920001CPZR

ADP3192AJCPZ-RL

ADP3192JCPZ-RL

ADP3193AJCPZ-RL

ADP3193JCPZ-RL

ADP3198001CPZR ADP3198AJCPZ-RL

ADP3198JCPZ-RL

ADP3199AJCPZ-RL

ADP3199JCPZ-RL

ADP32070091CPZR

ADP3207A0091CPZR

ADP3207AJCPZ-RL

ADP3207JCPZ-RL

ADP32080001CPZR

ADP3208JCPZ-RL

ADP32090091CPZR

# **ON Semiconductor**



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ADP3209JCPZ-RL

ADP3228JCPZ-RL

ADP3228JCPZ-RL7

ADP3228JCPZ-U3

ADP3228XCPZ-RL

ADP3228XCPZ-RL7

ADP34190091RMZR

ADP3419JRMZ-REEL

ADP3808AJCPZ-RL

ADP3808JCPZ-RL

ADT7461A0001RMZR

ADT7461A0002RMZR

ADT7461AARMZ

ADT7461AARMZ-002

ADT7461AARMZ-2RL

ADT7461AARMZ2RL7

ADT7461AARMZ-R

ADT7461AARMZ-RL7

ADT7461AR

ADT7461ARM

ADT7461ARMZ

ADT7461ARMZ-002

ADT7461ARMZ-2R

ADT7461ARMZ-2RL7

ADT7461ARMZ-R7

ADT7461ARZ

ADT7461ARZ-REEL

ADT7461ARZ-REEL7

ADT7462ACPZ-5RL7

ADT7462ACPZ-R7

ADT7462ACPZ-REEL

ADT7473ARQZ ADT7473ARQZ-1

ADT7473ARQZ-1R7

ADT7473ARQZ-1RL

ADT7473ARQZ-REEL

ADT7473ARQZ-RL7

ADT7475ARQZ

ADT7475ARQZ-REEL

ADT7475ARQZ-RL7

ADT7476AARQZ

ADT7476AARQZ-R

ADT7476AARQZ-RL7

ADT7476ARQZ

ADT7476ARQZ-R7

ADT7476ARQZ-REEL

ADT7481ARMZ

ADT7481ARMZ-001

ADT7481ARMZ-1R7

ADT7481ARMZ-1RL

ADT7481ARMZ-R7

ADT7481ARMZ-REEL

ADT7482ARMZ

ADT7482ARMZ-REEL

ADT7482ARMZ-RL7

ADT7483AARQZ

# **ON Semiconductor**



## Final Product/Process Change Notification #16111

ADT7483AARQZ-R7

ADT7483AARQZ-RL

ADT7484AARMZ-R7

ADT7484AARMZ-RL

ADT7484AARZ-REEL

ADT7484AARZ-RL7

ADT7485AARMZ-R

ADT7485AARMZ-R7

ADT7486AARMZ-R7

ADT7486AARMZ-RL

ADT7488AARMZ-RL

ADT7488AARMZ-RL7

ADT7490ARQZ

ADT7490ARQZ-R7

ADT7490ARQZ-REEL

ASP0700JCPZ-RL

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